The IBE-215 is designed for inert gas ion beam etching as well as for reactive ion beam etching. He-backside cooling, SIMS for end point detection, interface for clean room, beam monitoring with Faraday cup array and other helpful features are available.



TECHNICAL DATA

WORK PIECE DATA

Size: $\emptyset 215 \text{ mm} - 152.4 \text{ mm x } 152.4 \text{mm}$

 $(\emptyset 8.5^{"} - 6^{"} \times 6^{"})$

Thickness: 20 mm (0.8")

Weight: max. 2 kg (4.4 lbs)

Contact angle: $0 - 90^{\circ}$ Rotation speed: 0 - 10 rpm

Shape: plane, spherical, aspherical, freeform

SINGLE LOAD LOCK SYSTEM

Loading time: < 2min.

AXIS SYSTEM

Type: 215 X, Y, A, B Travel: X > 500 mm Y = 300 mm

 $A \pm 95^{\circ}$ B = 360°

DIMENSIONS

Weight: 2000 kg (4400 lbs) WxHxD: 2.8 m x 2.4 m x 1.4 m

(110" x 94" x 55")

Footprint: 4 m x 2 m

(157" x 79")

(R)-IBE**215**



